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 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

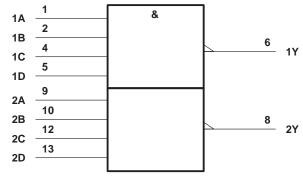
These devices contain two independent 4-input positive-NAND gates. They perform the Boolean functions  $Y = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D}$  or  $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$  in positive logic.

The SN54ALS20A and SN54AS20 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS20A and SN74AS20 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INP	UTS		OUTPUT
Α	В	С	D	Y
Н	Н	Н	Н	L
L	Χ	Χ	Χ	Н
X	L	Χ	Χ	Н
Х	Χ	L	Χ	Н
X	X	X	L	Н

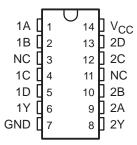
# logic symbol†



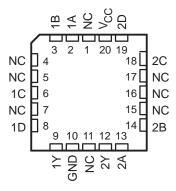
<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

#### SN54ALS20A, SN54AS20 . . . J PACKAGE SN74ALS20A, SN74AS20 . . . D OR N PACKAGE (TOP VIEW)

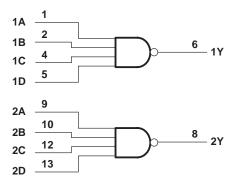


SN54ALS20A, SN54AS20 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

#### logic diagram (positive logic)



## SN54ALS20A, SN54AS20, SN74ALS20A, SN74AS20 DUAL 4-INPUT POSITIVE-NAND GATES

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN54ALS20A	55°C to 125°C
SN74ALS20A	0°C to 70°C
Storage temperature range	65°C to 150°C

#### recommended operating conditions

		SN	54ALS2	0A	SN74ALS20A MIN NOM MAX	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V <sub>IH</sub>	High-level input voltage	2			2			V
\/	Low-level input voltage			0.8‡			0.8	V
VIL	Low-level input voltage			0.7§				V
IOH	High-level output current			-0.4			-0.4	mA
lOL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

<sup>‡</sup> Applies over temperature range -55°C to 70°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	MOITIONS	SN	SN54ALS20A		SN74ALS20A			UNIT
PARAMETER	TEST CONDITIONS		MIN	TYP¶	MAX	MIN	TYP¶	MAX	UNII
VIK	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.5			-1.5	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2	2		V <sub>CC</sub> -2	2		V
V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
VOL	VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	V
lį	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
Ι <sub>Ι</sub> Γ	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA
lo <sup>#</sup>	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
Iссн	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0		0.22	0.4		0.22	0.4	mA
ICCL	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 4.5 V		0.81	1.5		0.81	1.5	mA

<sup>¶</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> Applies over temperature range 70°C to 125°C

<sup>#</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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#### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	то (ОИТРИТ)	V <sub>C</sub> C <sub>L</sub> R <sub>L</sub> T <sub>A</sub>	UNIT			
			SN54AI MIN	MAX	SN74AI MIN	MAX	
t <sub>PLH</sub>	A B C or D	V	1	12.5	3	11	200
t <sub>PHL</sub>	A, B, C, or D	ſ	1	11	3	10	ns

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN54AS20	
SN74AS20	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		S	N54AS2	0	S	N74AS2	)	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		S	SN54AS20			SN74AS20			
PARAMETER	1231 0	UNDITIONS	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -	2		V <sub>CC</sub> -2	2		V	
VOL	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V	
lį	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA	
liΗ	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 2.7 V			20			20	μΑ	
l <sub>IL</sub>	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0.4 V			-0.5			-0.5	mA	
ΙΟ <sup>¶</sup>	$V_{CC} = 5.5 V,$	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA	
Іссн	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0		1	1.6		1	1.6	mA	
<sup>I</sup> CCL	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 4.5 V		5.4	8.7		5.4	8.7	mA	

<sup>§</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



# SN54ALS20A, SN54AS20, SN74ALS20A, SN74AS20 DUAL 4-INPUT POSITIVE-NAND GATES

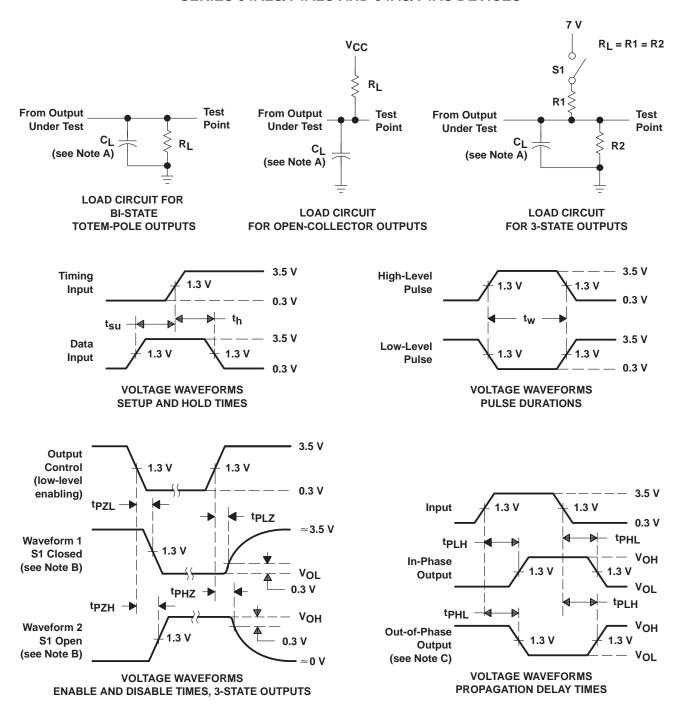
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## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>C</sub> C <sub>L</sub> R <sub>L</sub> T <sub>A</sub>	UNIT			
			SN54	AS20	SN74/	4520	
			MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	A, B, C, or D	V	1	5.5	1	5	ns
<sup>†</sup> PHL	А, Б, С, 01 Б	'	1	5	1	4.5	113

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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